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Thank you for your cooperation and understanding,

WeEn Semiconductors



## **BYQ28X-200**

# Dual ultrafast rugged rectifier diode Rev. 02 — 5 February 2009

**Product data sheet** 

#### **Product profile** 1.

## 1.1 General description

Dual ultrafast epitaxial rectifier diodes in a SOT186A (TO-220F) isolated plastic package.

#### 1.2 Features and benefits

- Fast switching
- Guaranteed ESD capability
- High thermal cycling performance
- Low on-state losses
- Soft recovery minimizes power-consuming oscillations

## 1.3 Applications

Output rectifiers in high-frequency switched-mode power supplies

## 1.4 Quick reference data

Table 1. **Quick reference** 

	Quion rolorollo					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{RRM}$	repetitive peak reverse voltage		-	-	200	V
I <sub>O(AV)</sub>	average output current	SQW; $\delta$ = 0.5; T <sub>h</sub> ≤ 92 °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	10	Α
I <sub>FRM</sub>	repetitive peak forward current	SQW; $\delta$ = 0.5; $t_p$ = 25 $\mu$ s; $T_h \le$ 92 °C; per diode	-	-	10	Α
Dynamic	characteristics					
t <sub>rr</sub>	reverse recovery time	$I_F = 1 \text{ A}$ ; $V_R = 30 \text{ V}$ ; $dI_F/dt = 100 \text{ A/}\mu\text{s}$ ; $T_j = 25 \text{ °C}$ ; ramp recovery; see Figure 5	-	15	25	ns
Static ch	aracteristics					
$V_{F}$	forward voltage	$I_F = 5 \text{ A}; T_j = 150 \text{ °C}; \text{ see}$ Figure 4	-	8.0	0.895	V
Electros	tatic discharge					
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 kΩ; all pins	-	-	8	kV
	<del></del>					



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## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode 1		
2	K	cathode	mb	A1 + + A2
3	A2	anode 2		<u> </u>
	n.c.	mounting base; isolated	1 2 3 SOT186A	sym125
			(TO-220F)	

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BYQ28X-200	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
_		Conditions	IVIIII		
$V_{RRM}$	repetitive peak reverse voltage		-	200	V
$V_{\text{RWM}}$	crest working reverse voltage		-	200	V
$V_R$	reverse voltage	DC	-	200	V
$I_{O(AV)}$	average output current	SQW; $\delta$ = 0.5; T <sub>h</sub> ≤ 92 °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	10	Α
I <sub>FRM</sub>	repetitive peak forward current	SQW; $\delta$ = 0.5; $t_p$ = 25 $\mu$ s; $T_h \le$ 92 °C; per diode	-	10	Α
I <sub>FSM</sub>	non-repetitive peak	$t_p = 10 \text{ ms; SIN; } T_{j(init)} = 25 \text{ °C; per diode}$	-	50	Α
	forward current	$t_p$ = 8.3 ms; SIN; $T_{j(init)}$ = 25 °C; per diode	-	55	Α
I <sub>RRM</sub>	repetitive peak reverse current	$t_p = 2 \ \mu s; \ \delta = 0.001$	-	0.2	Α
I <sub>RSM</sub>	non-repetitive peak reverse current	$t_p = 100 \ \mu s$	-	0.2	Α
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	150	°C
Electrosta	atic discharge				
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins	-	8	kV

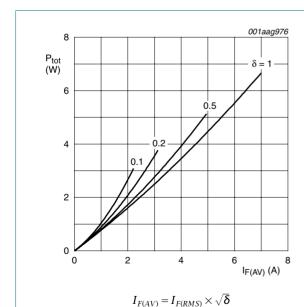


Fig 1. Forward power dissipation as a function of average forward current; square waveform; maximum values

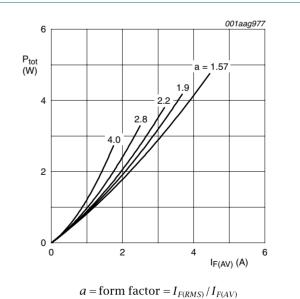


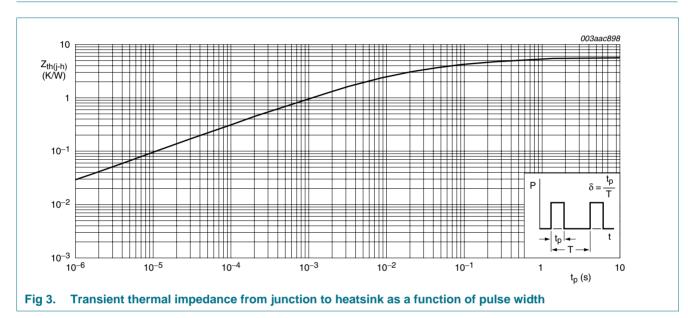
Fig 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values

Dual ultrafast rugged rectifier diode

## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-h)}$	thermal resistance from junction to heatsink	with heatsink compound; see Figure 3	-	-	5.7	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient free air		-	55	-	K/W



## 6. Isolation characteristics

Table 6. Isolation characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	50 Hz < f < 60 Hz; sinusoidal waveform; relative humidity < 65 %; clean and dust free; from all terminals to external heatsink	-	-	2500	V
C <sub>isol</sub>	isolation capacitance	from cathode to external heatsink; f = 1 MHz	-	10	-	pF

## 7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{F}$	forward voltage	I <sub>F</sub> = 10 A; T <sub>j</sub> = 25 °C	-	1.1	1.25	V
		$I_F = 5 \text{ A}; T_j = 150 \text{ °C}; \text{ see } \frac{\text{Figure 4}}{\text{Minimum 1}}$	-	8.0	0.895	V
		I <sub>F</sub> = 5 A; T <sub>j</sub> = 25 °C	-	0.95	1.1	V
$I_R$	reverse current	V <sub>R</sub> = 200 V; T <sub>j</sub> = 25 °C	-	2	10	μΑ
		V <sub>R</sub> = 200 V; T <sub>j</sub> = 100 °C	-	0.1	0.2	mA
Dynamic	characteristics					
Q <sub>r</sub>	recovered charge	$I_F = 2 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 20 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}$	-	4	9	μC
t <sub>rr</sub>	reverse recovery time	$I_F = 1 \text{ A}$ ; $V_R = 30 \text{ V}$ ; $dI_F/dt = 100 \text{ A/}\mu\text{s}$ ; ramp recovery; $T_j = 25 \text{ °C}$ ; see Figure 5	-	15	25	ns
		$I_F$ = 0.5 A; $I_R$ = 1 A; step recovery; measured at $I_R$ = 0.25 A; $T_j$ = 25 °C; see Figure 6	-	-	20	ns
I <sub>RM</sub>	peak reverse recovery current	$I_F = 5 \text{ A}; V_R \ge 30 \text{ V}; dI_F/dt = 50 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 5}}{}$	-	0.5	0.7	Α
$V_{FRM}$	peak forward recovery voltage	$I_F = 1 \text{ A}$ ; $dI_F/dt = 10 \text{ A/}\mu\text{s}$ ; $T_j = 25 \text{ °C}$ ; see Figure 7	-	1	-	V

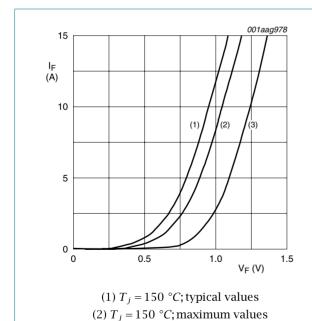


Fig 4. Forward current as a function of forward voltage

(3)  $T_j = 25$  °C; maximum values

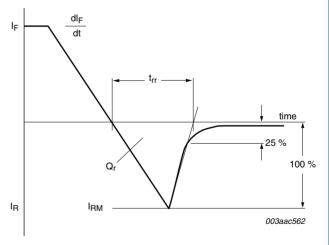
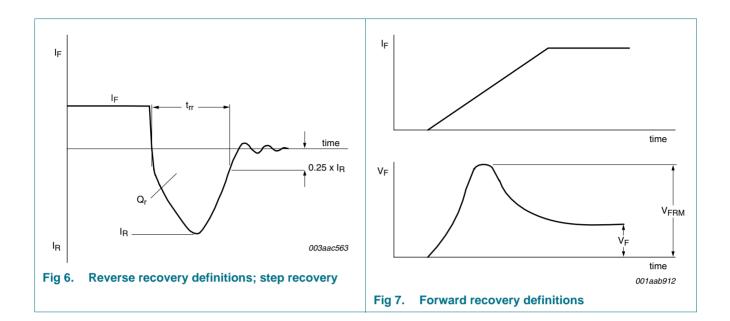


Fig 5. Reverse recovery definitions; ramp recovery

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## Dual ultrafast rugged rectifier diode

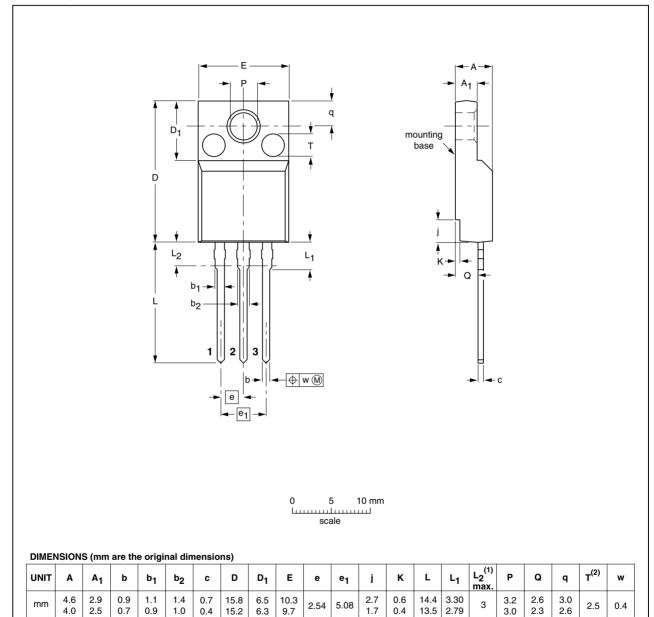


## 8. Package outline

Plastic single-ended package; isolated heatsink mounted;

1 mounting hole; 3-lead TO-220 'full pack'

SOT186A



#### Notes

- 1. Terminal dimensions within this zone are uncontrolled.
- 2. Both recesses are  $\varnothing$  2.5  $\times$  0.8 max. depth

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	1330E DATE
SOT186A		3-lead TO-220F			<del>02-04-09</del> 06-02-14

Fig 8. Package outline SOT186A (TO-220F)



## Dual ultrafast rugged rectifier diode

## 9. Revision history

## Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BYQ28X-200_2	20090205	Product data sheet	-	BYQ28X_SERIES_1		
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>					
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>					
	<ul> <li>Type numb</li> </ul>	er BYQ28X-200 separate	ed from data sheet BYQ	28X_SERIES_1.		
BYQ28X_SERIES_1	19960801	Product data sheet	-	-		

**BYQ28X-200** 

#### Dual ultrafast rugged rectifier diode

## 10. Legal information

#### 10.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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